Application/Control No. Applicant(s)/Patent Under Reexamination 10/712,194 LEIFER, RICHARD Notice of References Cited Examiner Art Unit Page 1 of 1 2875 Anabel M. Ton **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2004/0160769 08-2004 Currie et al. 362/232 Α 362/555 В US-6,648,496 11-2003 Eighoroury et al. 439/86 С US-6,171,117 01-2001 Chien, Tseng-Lu D US-US-Ε F US-G US-Н US-US-1 US-J US-Κ L US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition & Volume, Pertinent Pages) U ٧ W

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